Application/Control No. Applicant(s)/Patent Under Reexamination 09/731,060 **NEVILL ET AL.** Notice of References Cited Examiner Art Unit Page 1 of 1 Li B. Zhen 2194 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,374,286 04-2002 Gee et al. 718/108 Α US-6,332,215 12-2001 Patel et al. 717/141 В US-6,338,160 01-2002 Patel et al. 717/139 С US-D US-Ε US-F US-G US-Н USı US-J US-K US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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